Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/689,181	LAIWALLA ET AL.
Examiner	Art Unit

Ahshik Kim

2876

SEARCHED				
Class	Subclass	Date	Examiner	
235	449	12/15/2006	AK	
	383			
	375			
	380			
V	379			
705	64			
A	73	ł	1	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See attached EAST search history	12/15/2006	AK		